

Notice of References Cited

Application/Control No.

09/786,990

Applicant(s)/Patent Under
Reexamination
ONISHI ET AL.

Examiner

DEVONA E. FAULK

Art Unit

2614

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,282,296	08-2001	Konno et al.	381/96
*	B	US-6,122,385	09-2000	Konno et al.	381/96
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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